Docket No.: 21058/1206448-US1 (PATENT)

Examiner: F. W. Lu

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Selena Chan et al.

Application No.: 10/667,004 Confirmation No.: 6646

Filed: September 19, 2003 Art Unit: 1634

For: CONTROLLED ALIGNMENT OF

NANOBARCODES ENCODING SPECIFIC INFORMATION FOR SCANNING PROBE MICROSCOPY (SPM) READING

RESPONSE TO REASONS FOR ALLOWANCE

MS Issue Fee Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Notice of Allowance, dated September 8, 2008, Applicants respectfully submit for the record that the changes made in the "Amendment After Allowance under 37 C.F.R. 1.312" filed on May 13, 2008 and the "Supplemental Amendment After Allowance under 37 C.F.R. 1.312" filed on May 14, 2008 have been incorporated by the Examiner via Examiner's Amendment attached to the Notice of Allowability.

Dated: November 20, 2008 Respectfully submitted.

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